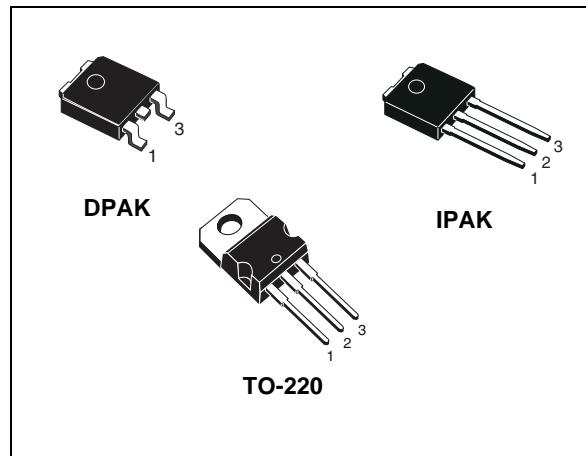


N-channel 30 V, 0.0042 Ω , 80 A, DPAK, TO-220, IPAK
STripFET™ V Power MOSFET

Features

Type	V_{DSS}	$R_{DS(on)} \text{ max}$	I_D
STD85N3LH5	30 V	< 0.005 Ω	80 A
STP85N3LH5	30 V	< 0.0054 Ω	80 A
STU85N3LH5	30 V	< 0.0054 Ω	80 A

- $R_{DS(on)} * Q_g$ industry benchmark
- Extremely low on-resistance $R_{DS(on)}$
- High avalanche ruggedness
- Low gate drive power losses



Application

- Switching applications

Description

This product utilizes the 5th generation of design rules of ST's proprietary STripFET™ technology. The lowest available $R_{DS(on)} * Q_g$, in the standard packages, makes this device suitable for the most demanding DC-DC converter applications, where high power density is to be achieved.

Figure 1. Internal schematic diagram

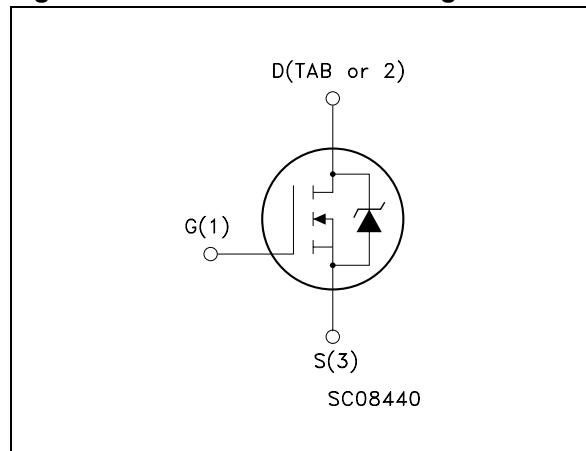


Table 1. Device summary

Order codes	Marking	Package	Packaging
STD85N3LH5	85N3LH5	DPAK	Tape and reel
STP85N3LH5	85N3LH5	TO-220	Tube
STU85N3LH5	85N3LH5	IPAK	Tube

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
2.1	Electrical characteristics (curves)	6
3	Test circuit	8
4	Package mechanical data	10
5	Packaging mechanical data	13
6	Revision history	14

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage ($V_{GS} = 0$)	30	V
V_{DS}	Drain-source voltage ($V_{GS} = 0$) @ T_{JMAX}	35	V
V_{GS}	Gate-source voltage	± 22	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25^\circ C$	80	A
I_D	Drain current (continuous) at $T_C = 100^\circ C$	55	A
$I_{DM}^{(2)}$	Drain current (pulsed)	320	A
P_{TOT}	Total dissipation at $T_C = 25^\circ C$	70	W
	Derating factor	0.47	W/ $^\circ C$
$E_{AS}^{(3)}$	Single pulse avalanche energy	165	mJ
T_{stg}	Storage temperature	-55 to 175	$^\circ C$
T_j	Max. operating junction temperature	175	$^\circ C$

1. Limited by wire bonding
2. Pulse width limited by safe operating area
3. Starting $T_j = 25^\circ C$, $I_D = 40 A$, $V_{DD} = 25 V$

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	2.14	$^\circ C/W$
$R_{thj-amb}$	Thermal resistance junction-case max	100	$^\circ C/W$
T_j	Maximum lead temperature for soldering purpose	275	$^\circ C$

2 Electrical characteristics

($T_{CASE} = 25^\circ\text{C}$ unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown Voltage	$I_D = 250 \mu\text{A}$, $V_{GS} = 0$	30			V
I_{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	$V_{DS} = 20 \text{ V}$ $V_{DS} = 20 \text{ V}, T_c = 125^\circ\text{C}$			1 10	μA μA
I_{GSS}	Gate body leakage current ($V_{DS} = 0$)	$V_{GS} = \pm 22 \text{ V}$			± 100	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	1		2.5	V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}$, $I_D = 40 \text{ A}$ SMD version		0.042	0.005	Ω
		$V_{GS} = 10 \text{ V}$, $I_D = 40 \text{ A}$		0.0046	0.0054	Ω
		$V_{GS} = 5 \text{ V}$, $I_D = 40 \text{ A}$ SMD version		0.0052	0.0065	Ω
		$V_{GS} = 5 \text{ V}$, $I_D = 40 \text{ A}$		0.0058	0.0071	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
C_{iss}	Input capacitance					pF
C_{oss}	Output capacitance	$V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$,		1850		pF
C_{rss}	Reverse transfer capacitance	$V_{GS} = 0$		380		pF
				58		pF
Q_g	Total gate charge	$V_{DD} = 15 \text{ V}$, $I_D = 80 \text{ A}$		14		nC
Q_{gs}	Gate-source charge	$V_{GS} = 5 \text{ V}$		6.8		nC
Q_{gd}	Gate-drain charge	(see Figure 16)		4.7		nC
Q_{gs1}	Pre V_{th} gate-to-source charge	$V_{DD} = 15 \text{ V}$, $I_D = 80 \text{ A}$		2.3		nC
Q_{gs2}	Post V_{th} gate-to-source charge	$V_{GS} = 5 \text{ V}$ (see Figure 19)		4.5		nC
R_G	Gate input resistance	$f = 1 \text{ MHz}$ gate bias Bias = 0 test signal level = 20 mV open drain		1.2		Ω

Table 6. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on delay time Rise time	$V_{DD} = 15 \text{ V}$, $I_D = 40 \text{ A}$, $R_G = 4.7 \Omega$, $V_{GS} = 5 \text{ V}$ (see Figure 15)		6 14		ns ns
$t_{d(off)}$ t_f	Turn-off delay time Fall time	$V_{DD} = 15 \text{ V}$, $I_D = 40 \text{ A}$, $R_G = 4.7 \Omega$, $V_{GS} = 5 \text{ V}$ (see Figure 15)		23.6 10.8		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} $I_{SDM}^{(1)}$	Source-drain current Source-drain current (pulsed)				80 320	A A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 40 \text{ A}$, $V_{GS} = 0$			1.1	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 80 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$, $V_{DD} = 20 \text{ V}$ (see Figure 17)		31.8 26.1 1.6		ns nC A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

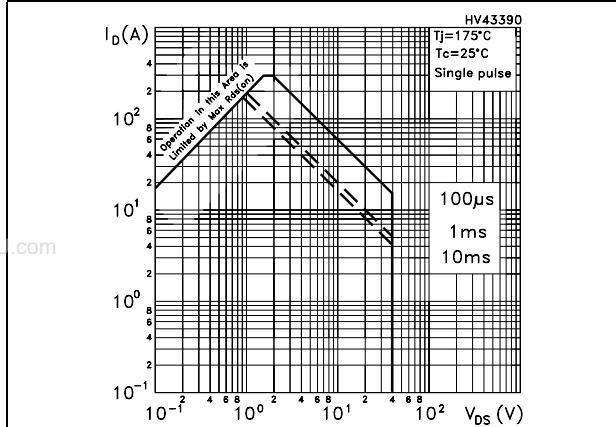


Figure 3. Thermal impedance

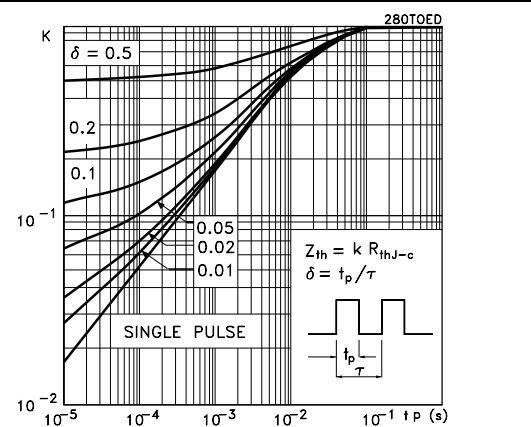


Figure 4. Output characteristics

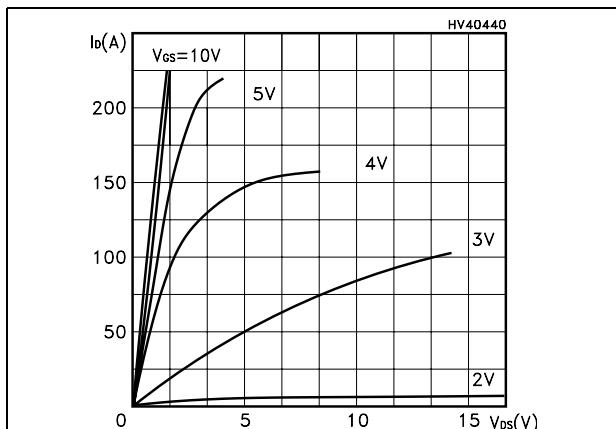


Figure 5. Transfer characteristics

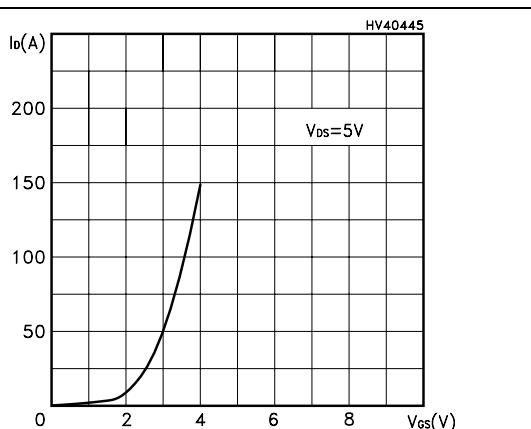


Figure 6. Normalized B_VDSS vs temperature

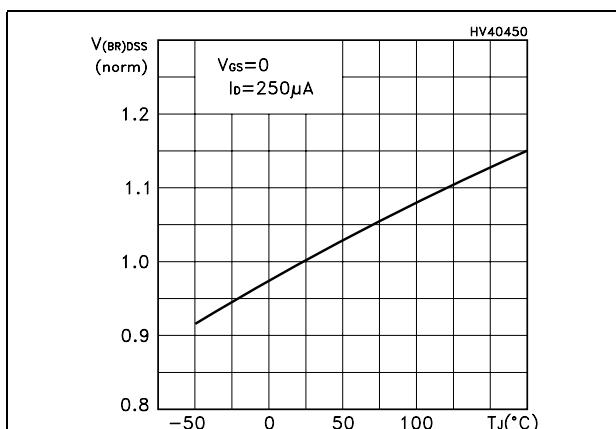


Figure 7. Static drain-source on resistance

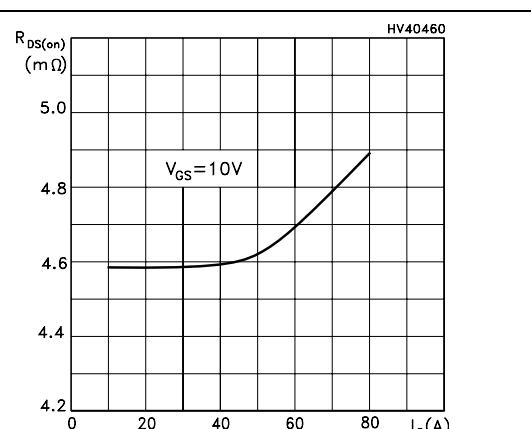
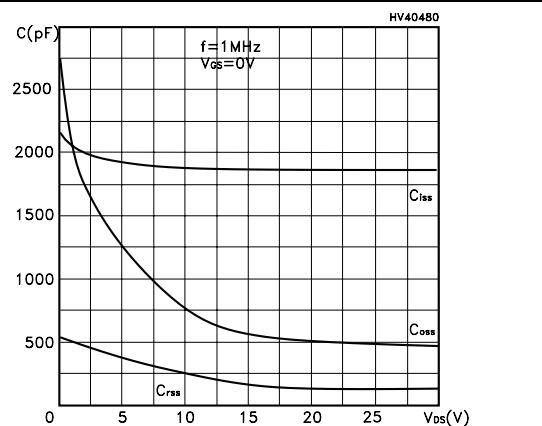
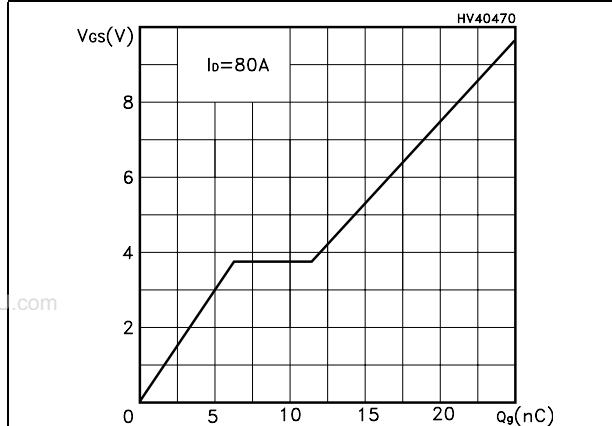
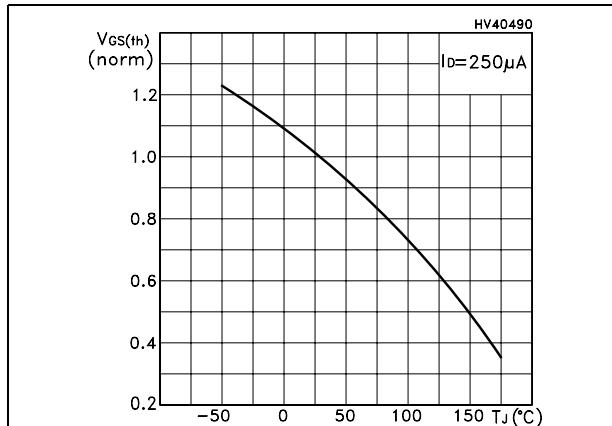
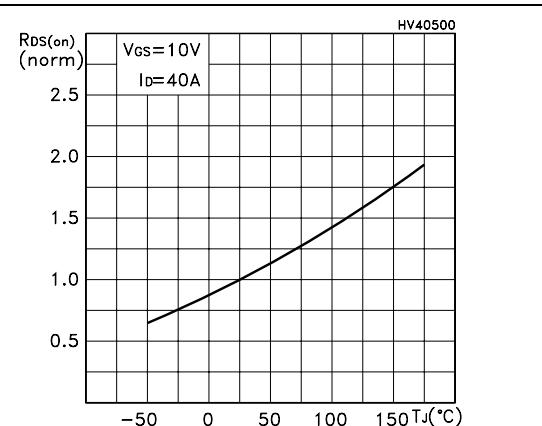
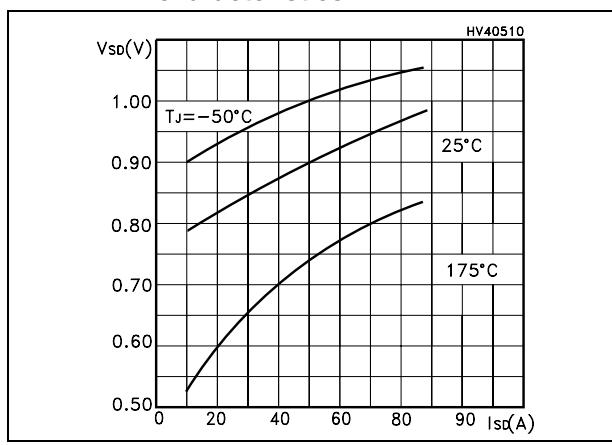


Figure 8. Gate charge vs gate-source voltage**Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on resistance vs temperature****Figure 12. Source-drain diode forward characteristics**

3 Test circuit

Figure 13. Unclamped inductive load test circuit

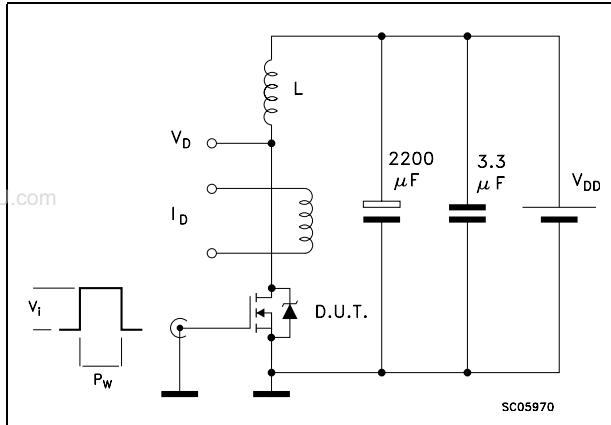


Figure 14. Unclamped inductive waveform

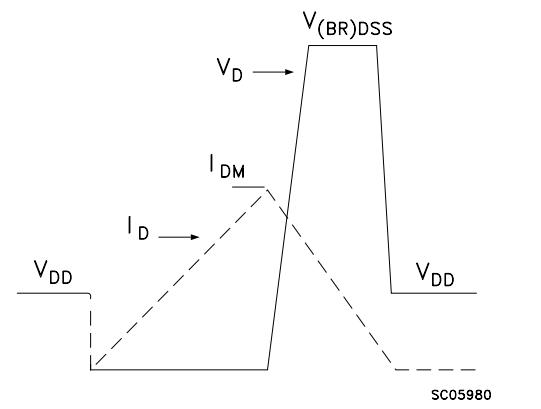


Figure 15. Switching times test circuit for resistive load

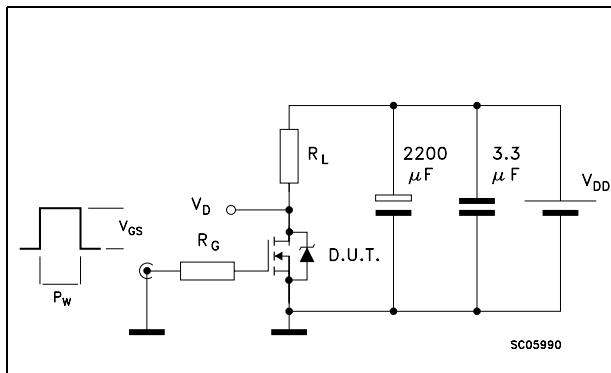


Figure 16. Gate charge test circuit

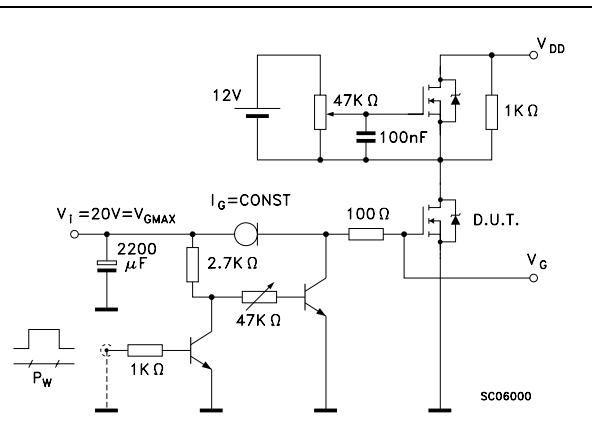


Figure 17. Test circuit for inductive load switching and diode recovery times

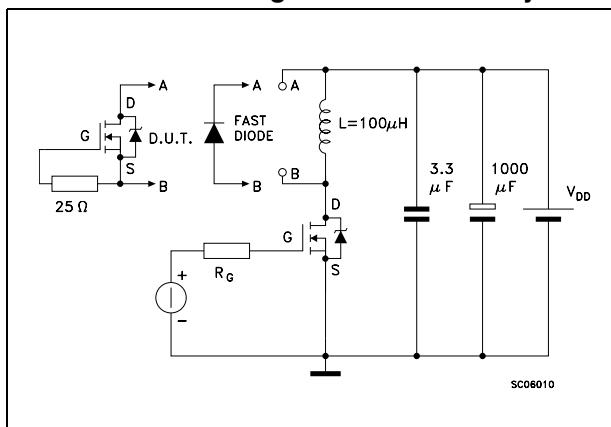


Figure 18. Switching time waveform

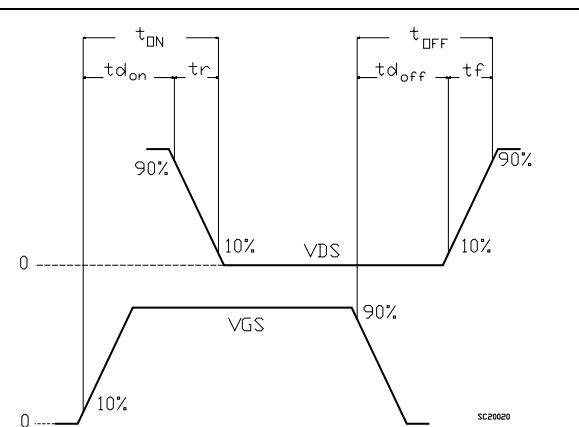
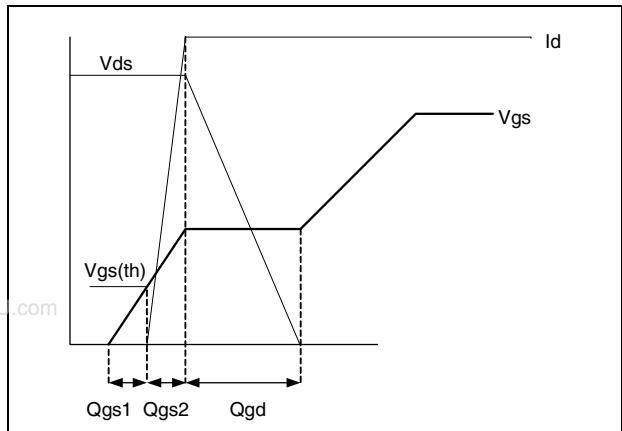


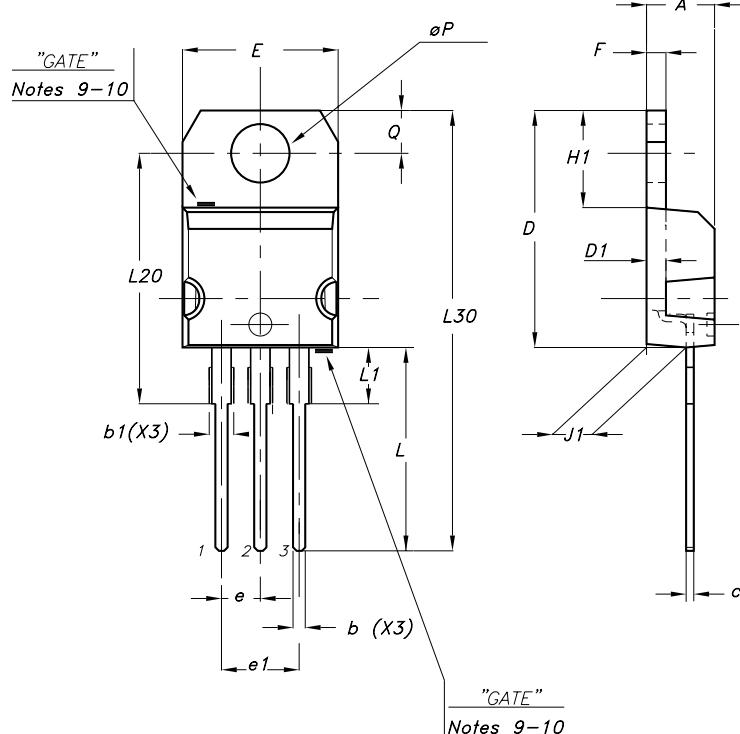
Figure 19. Gate charge waveform

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

TO-220 mechanical data

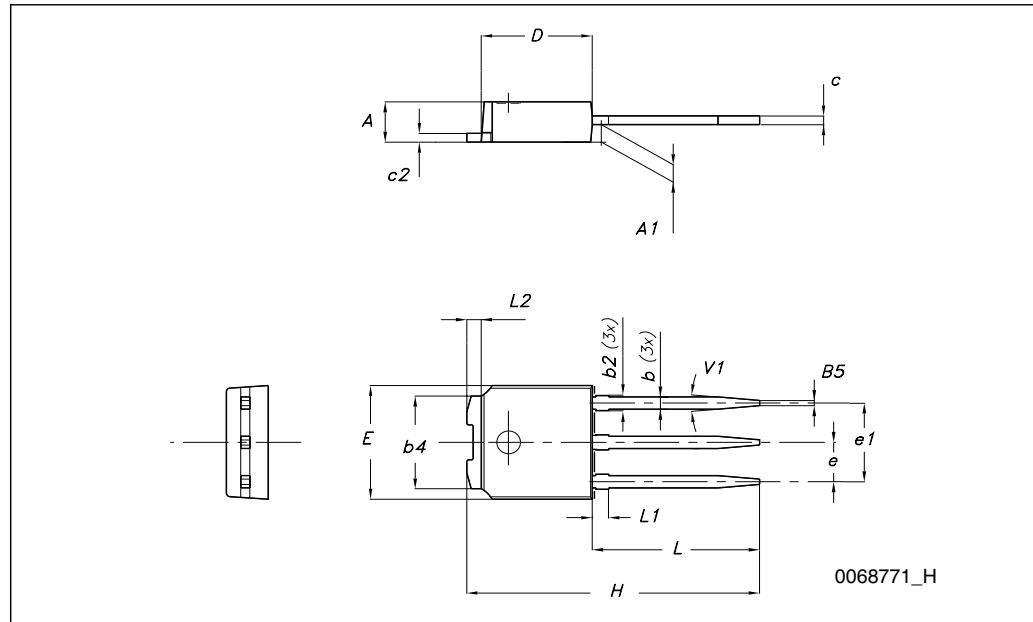
Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.48		0.70	0.019		0.027
D	15.25		15.75	0.6		0.62
D1		1.27			0.050	
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.051
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
$\emptyset P$	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



0015988_Rev_R

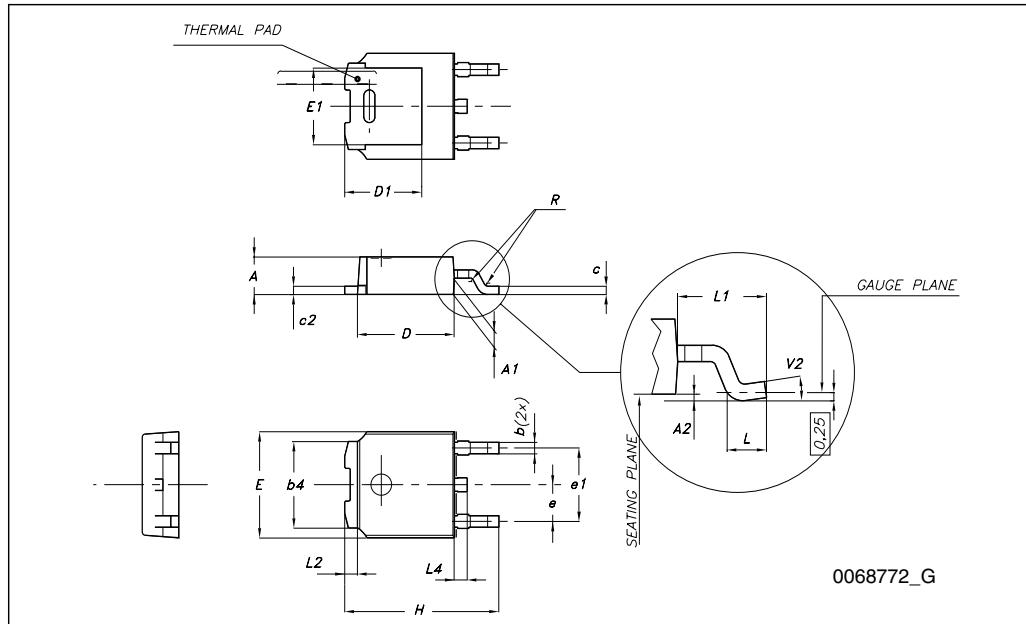
TO-251 (IPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
(L1)	0.80		1.20
L2		0.80	
V1		10 °	

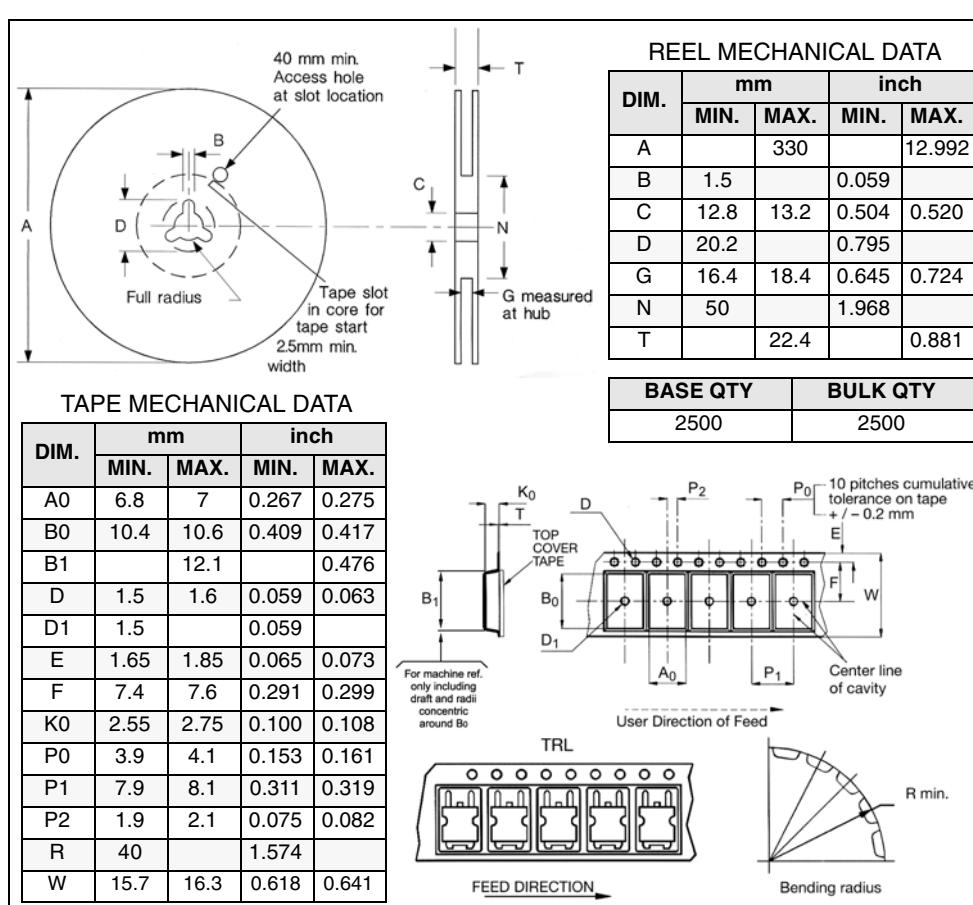
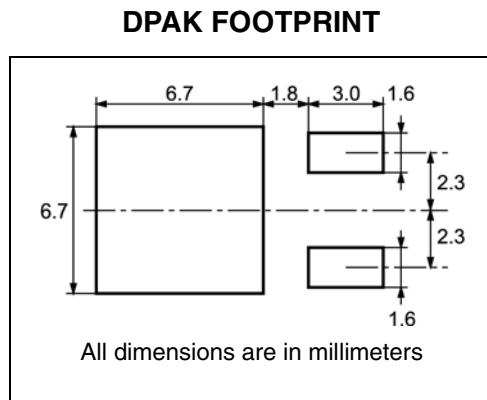


TO-252 (DPAK) mechanical data			
DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0 °		8 °

DIM.	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0 °		8 °



5 Packaging mechanical data



6 Revision history

Table 8. Document revision history

Date	Revision	Changes
19-Oct-2007	1	First release
20-Feb-2008	2	Minor text changes to improve readability
21-Jul-2008	3	<ul style="list-style-type: none">– Added new package, mechanical data: TO-220– <i>Figure 2: Safe operating area</i> has been corrected– <i>Figure 7: Static drain-source on resistance</i> updated– New value on <i>Table 2: Absolute maximum ratings</i>
20-Aug-2008	4	Added max value on $V_{GS(th)}$ (<i>Table 4</i>)
25-Sep-2008	5	V_{GS} values has been changed on <i>Table 2</i> and <i>Table 4</i>

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